

SEMiX 604GB126HDs



Trench IGBT Modules

SEMiX 604GB126HDs

Preliminary Data

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperatur limited to $T_C=125^\circ\text{C}$ max.



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Absolute Maximum Ratings		$T_{case} = 25^\circ\text{C}$, unless otherwise specified		
Symbol	Conditions	Values	Units	
IGBT				
V_{CES}	$T_J = 25^\circ\text{C}$	1200	V	
I_C	$T_J = 150^\circ\text{C}$	$T_C = 25^\circ\text{C}$	595	A
		$T_C = 80^\circ\text{C}$	415	A
I_{CRM}	$I_{CRM} = 2 \times I_{Crom}$	800	A	
V_{GES}		± 20	V	
I_{psc}	$V_{CC} = 600\text{ V}; V_{GE} \leq 20\text{ V}; T_J = 125^\circ\text{C}$ $V_{CES} < 1200\text{ V}$	10	μs	
Inverse Diode				
I_F	$T_J = 150^\circ\text{C}$	$T_C = 25^\circ\text{C}$	535	A
		$T_C = 80^\circ\text{C}$	370	A
I_{FRM}	$I_{FRM} = 2 \times I_{FRom}$	800	A	
I_{FSM}	$t_p = 10\text{ ms}; \sin.$	$T_J = 25^\circ\text{C}$	2500	A
Module				
$I_{T(RMS)}$		600	A	
T_{vj}		- 40 ... + 150	$^\circ\text{C}$	
T_{stg}		- 40 ... + 125	$^\circ\text{C}$	
V_{isol}	AC, 1 min.	4000	V	

Characteristics		$T_{case} = 25^\circ\text{C}$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}; I_C = 16\text{ mA}$	5	5,8	6,5	V	
I_{CES}	$V_{GE} = 0\text{ V}; V_{CE} = V_{CES}$		$T_J = 25^\circ\text{C}$	0,3	mA	
			$T_J = 125^\circ\text{C}$	1	1,2	V
V_{CE0}			$T_J = 25^\circ\text{C}$	0,9	1,1	V
			$T_J = 125^\circ\text{C}$	1,8	2,4	m Ω
r_{CE}	$V_{CE} = 15\text{ V}$		$T_J = 25^\circ\text{C}$	2,8	3,4	m Ω
			$T_J = 125^\circ\text{C}$	1,7	2,15	V
$V_{CE(sat)}$	$I_{Crom} = 400\text{ A}; V_{GE} = 15\text{ V}$		$T_J = 25^\circ\text{C}_{chiplev.}$	2	2,45	V
			$T_J = 125^\circ\text{C}_{chiplev.}$	28,8	1,51	nF
C_{ios}	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$		1,31	nF	
C_{oss}				3200	nC	
C_{res}				330	ns	
Q_G	$V_{GE} = -8 \dots +15\text{ V}$		70	ns		
$t_{s(on)}$	$R_{Con} = 2,2\ \Omega$	$V_{CC} = 600\text{ V}$ $I_{Crom} = 400\text{ A}$		36	mJ	
t_r				630	ns	
E_{on}	$R_{Coff} = 2,2\ \Omega$	$T_J = 125^\circ\text{C}$		130	ns	
$t_{s(off)}$				60	mJ	
t_f						
E_{off}						
$R_{th(j-c)}$	per IGBT			0,065	K/W	

SEMiX 604GB126HDs



SEMiX® 4s

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Characteristics

Symbol	Conditions	min.	typ.	max.	Units
Inverse Diode					
$V_F = V_{EC}$	$I_{Fnom} = 400\text{ A}; V_{GE} = 0\text{ V}$	$T_J = 25^\circ\text{C}_{chiplev.}$	1,6	1,8	V
		$T_J = 125^\circ\text{C}_{chiplev.}$	1,6	1,8	V
V_{FO}		$T_J = 25^\circ\text{C}$	1	1,1	V
		$T_J = 125^\circ\text{C}$	0,8	0,9	V
r_F		$T_J = 25^\circ\text{C}$	1,5	1,8	mΩ
		$T_J = 125^\circ\text{C}$	2	2,3	mΩ
I_{RRM}	$I_{Fnom} = 400\text{ A}$	$T_J = 125^\circ\text{C}$	475		A
O_{rr}		$di/dt = 6200\text{ A}/\mu\text{s}$	100		μC
E_{rr}	$V_{GE} = -15\text{ V}; V_{CC} = 600\text{ V}$		46		mJ
$R_{\theta(j-c)}$	per diode			0,11	K/W
Module					
L_{DE}			22		nH
R_{CC+EE}	res., terminal-chip	$T_{case} = 25^\circ\text{C}$	0,7		mΩ
		$T_{case} = 125^\circ\text{C}$	1		mΩ
$R_{\theta(c-s)}$	per module		0,03		K/W
M_9	to heat sink (M5)		3	5	Nm
M_1	to terminals (M6)		2,5	5	Nm
w				400	g
Temperature sensor					
R_{100}	$T_c = 100^\circ\text{C}$ ($R_{25} = 5\text{ k}\Omega$)		0,493±5%		kΩ
$B_{100/125}$	$R(T) = R_{100} \exp\left[B_{100/125} \left(1/T - 1/T_{100}\right)\right]$; $T[\text{K}]$		3550±2%		K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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